



Design and Testing of a Reference PCB for Environmental Conditioning

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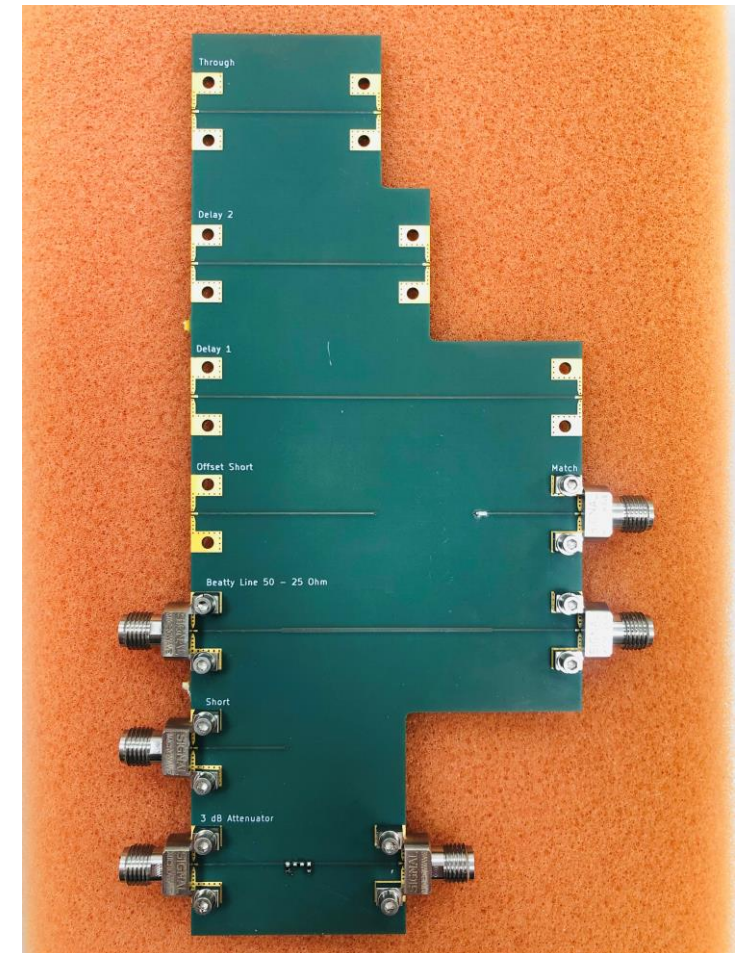
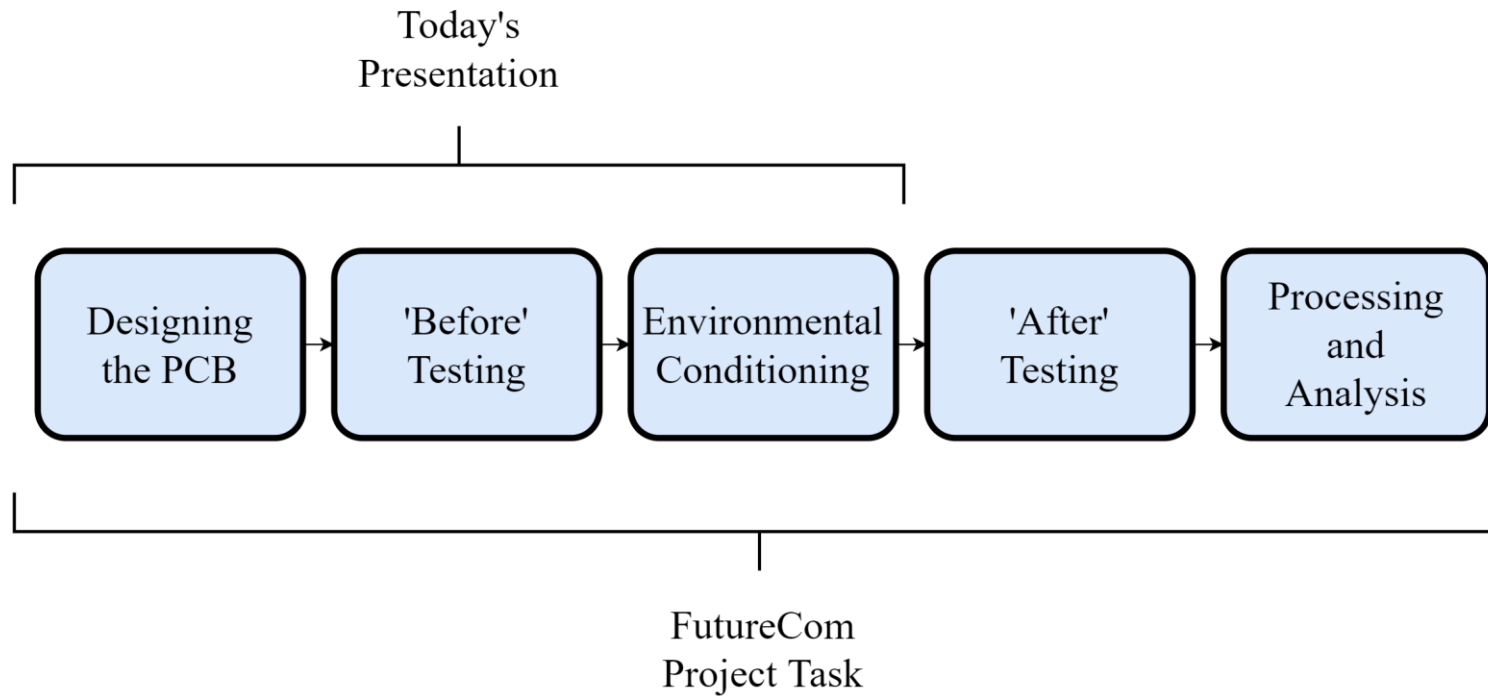


Background



- Part of the EMPIR-funded 'FutureCom' project
- Tackle challenges of implementing future communication technologies
- The focus is on RF and Microwave circuit performance in harsh environments
- Collaboration with IMBiH (Institute of Metrology of Bosnia & Herzegovina)

Outline



PCB Design Goals



- To learn *how* printed RF and Microwave circuits respond to harsh environments (temperature, humidity)
 - design goal: build a PCB that is representative of something that would be used in telecommunication technologies such as 5G, IoT, CAV...
 - design goal: use inexpensive PCB materials that work well in the sub 6 GHz band

PCB Formfactor



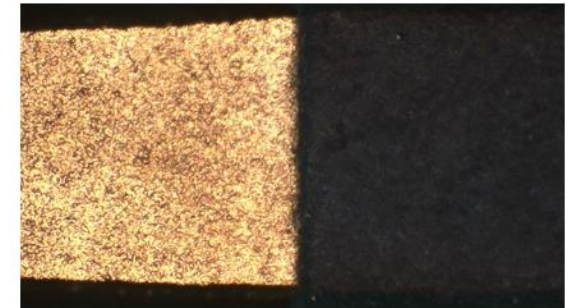
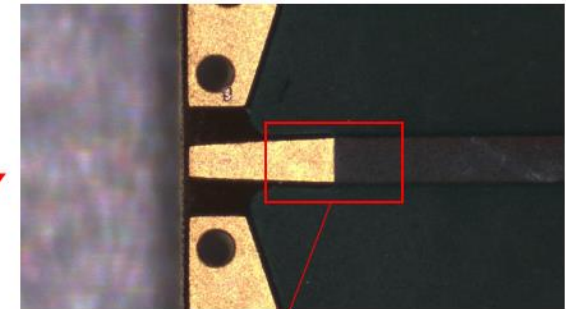
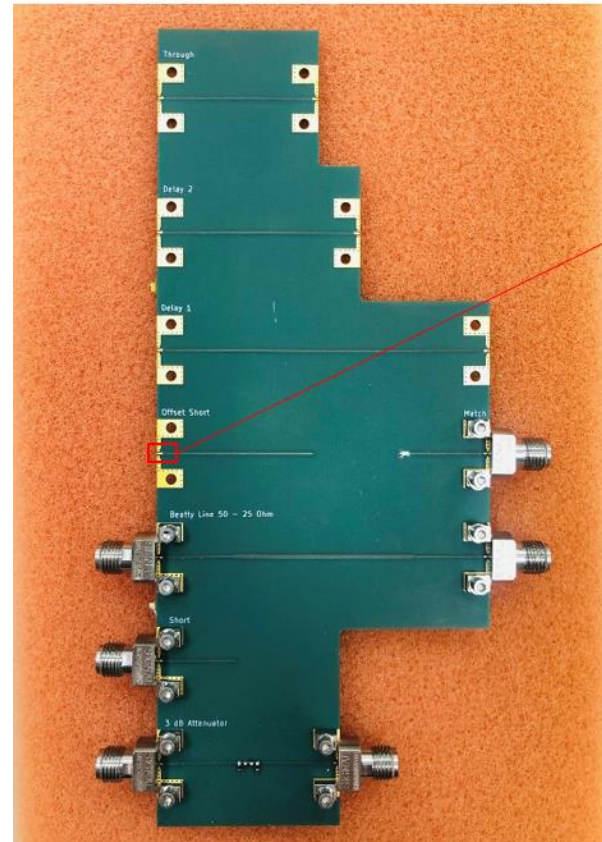
- 4-layer design
- Nominal 1.6 mm board thickness
- Chosen to emulate popular RF and microwave 4-layer PCBs

PCP	CAM	Layer	Material	Component	Pre-preg	Unitary	Cu Thk	P-Preg Qty	Layer Cu	% Copper	Effective	Impedance	Polar H	Avg Min	Drill / Sub
L No	L No	No	Type	Type	Style	Thickness	Adjustment	Final Cu	Area (Sq")	Coverage	Thickness	Layer Type	Values	Separation	Stacks
1	1	1		Foil		17.1	20.1	37.2	216.0	100%	37	Cl Sig			
			PCL 370HR	Pre-preg	2113,59	102		1			102	4.09	213	213	
			PCL 370HR	Pre-preg	2116,56	122		1			122	4.14			
2	2	2		Cu Layer		34.3	-3	31.3	137.5	64%	20	Cl Ref-Plane			
			PCL 370HR	Core	0.991ML	1000					1000		N/A	1000	
3	3	3		Cu Layer		34.3	-3	31.3	137.5	64%	20	Cl Ref-Plane			
			PCL 370HR	Pre-preg	2116,56	122		1			122	4.14	213	213	
			PCL 370HR	Pre-preg	2113,59	102		1			102	4.09			
4	4	4		Foil		17.1	20.1	37.2	216.0	100%	37.2	Cl Sig			

PCB Materials



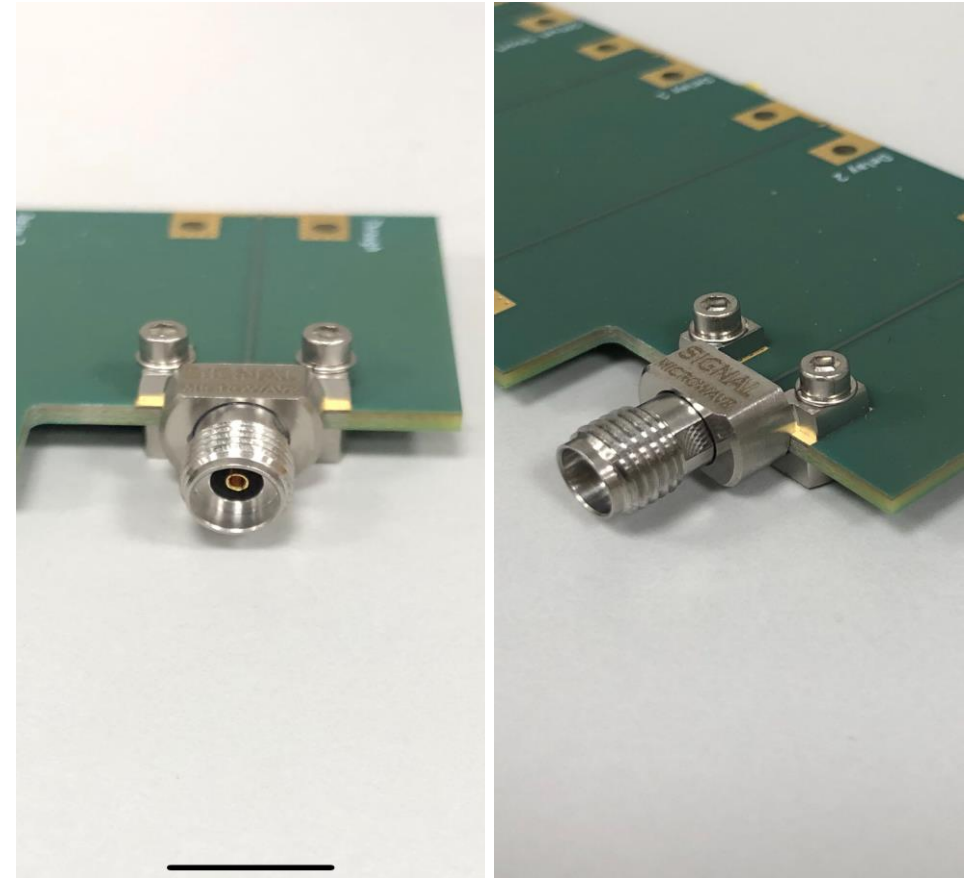
- Isola 370 HR prepreg + core
- Soldermask
- Electroless nickel immersionless gold (ENIG) finish
- Selective finishing



Connectorisation



- Metrology grade 2.92 mm end-launch connectors
- Screw connectors allows for isolation of PCB's response to environmental conditioning

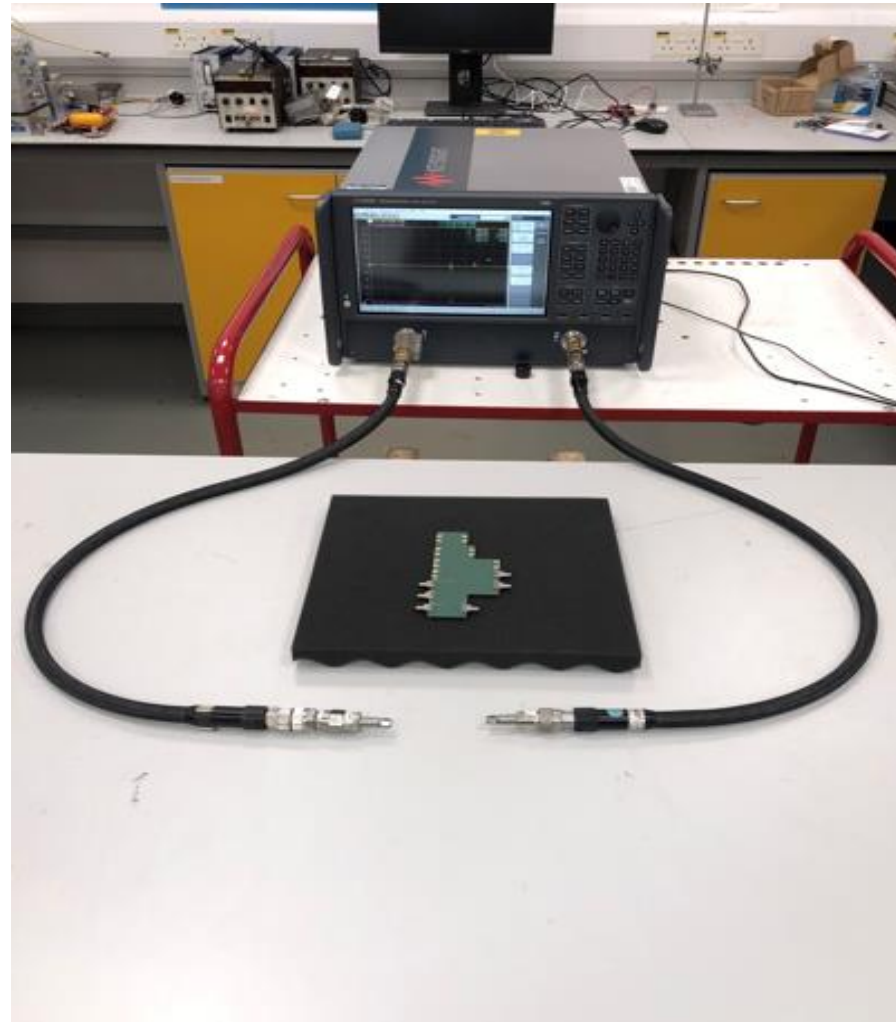


PCB Measurement Setup



NPL 

FUTURECOM 
RF Measurements for future communications applications

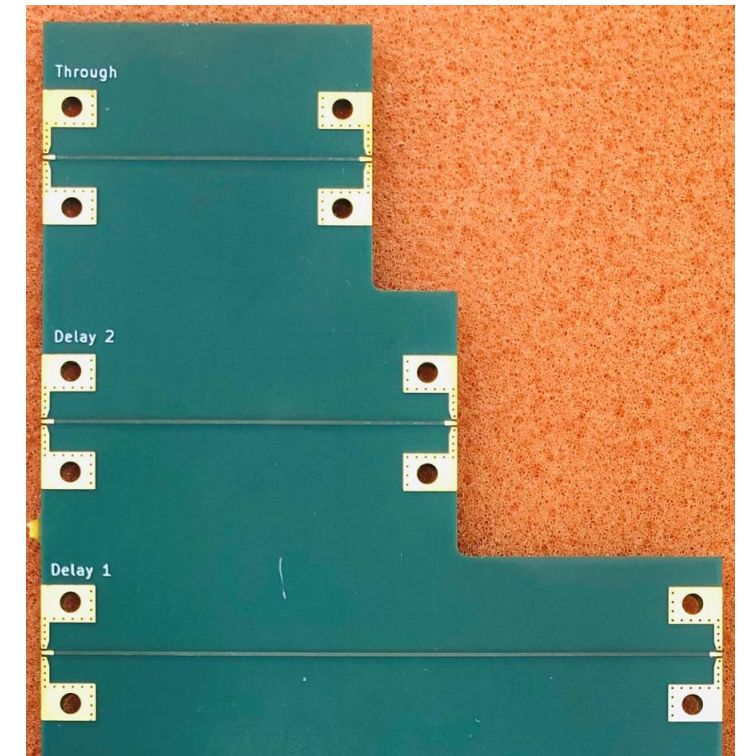


RF and Microwave Measurements



- Basic printed structures used to assess the performance of the circuits:

Structure	Description
Through	Connector launches + track length (28.74 mm)
Delay 1	Connector launches + track length (61.92 mm)
Delay 2	Connector launches + track length (36.79 mm)
Beatty Line	Connector launches + 14.36 mm length of 376 μm width track + 33.08 mm length of 743 μm width track + 14.47 mm length of 376 μm width track (tapered transitions between different widths of track)
Short	Connector launch + track length 14.37 mm + via to ground
Offset Short	Connector launch + track length 29.10 mm + via to ground
Load	Connector launch + track length 14.37 mm + 50 ohm surface mount resistor to ground
3 dB Attenuator	Connector launch + track length 14.37 mm + pi network of surface mount resistors with a nominal 3 dB attenuation + track length 14.37 mm



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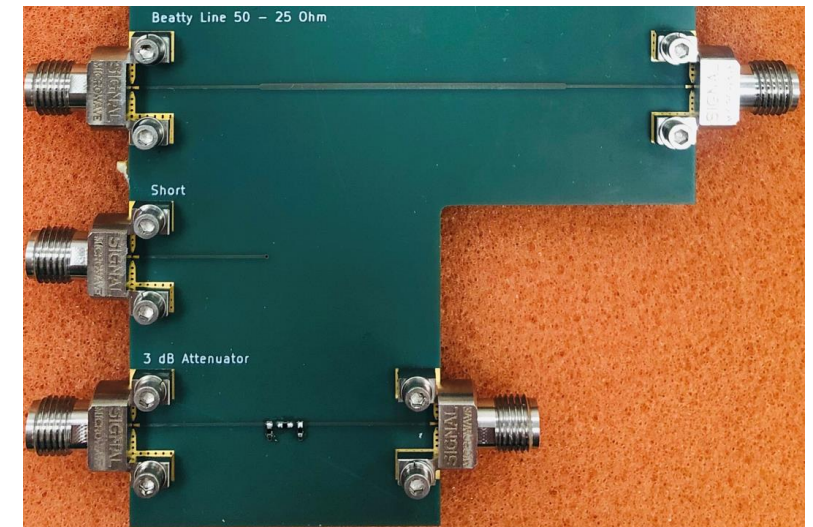


RF and Microwave Measurements



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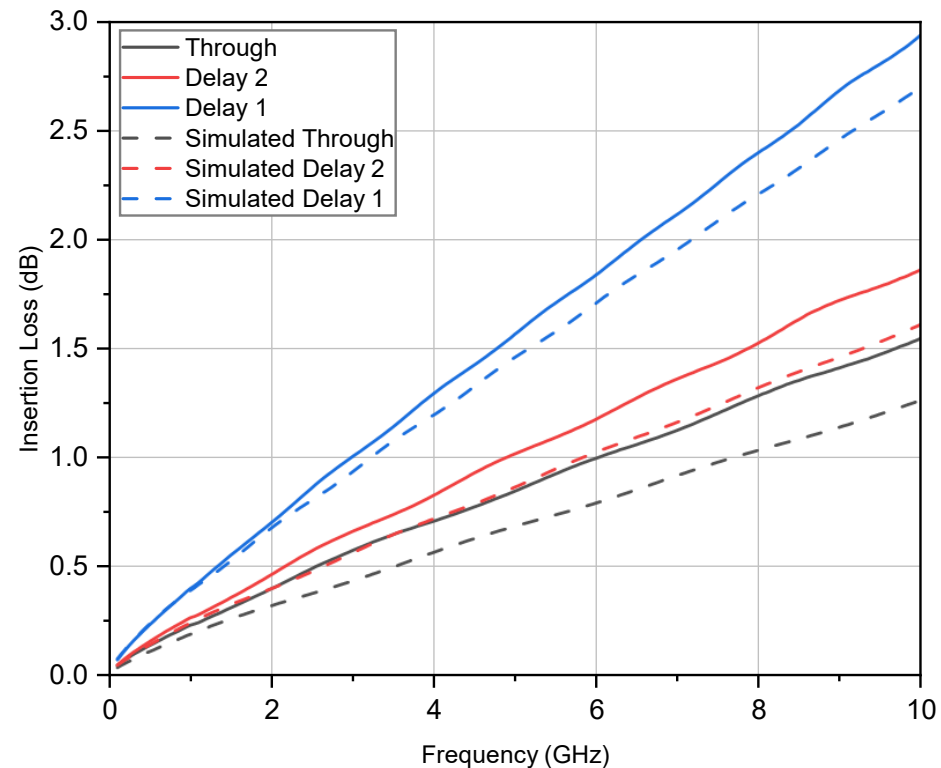
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Some 'Before' Data



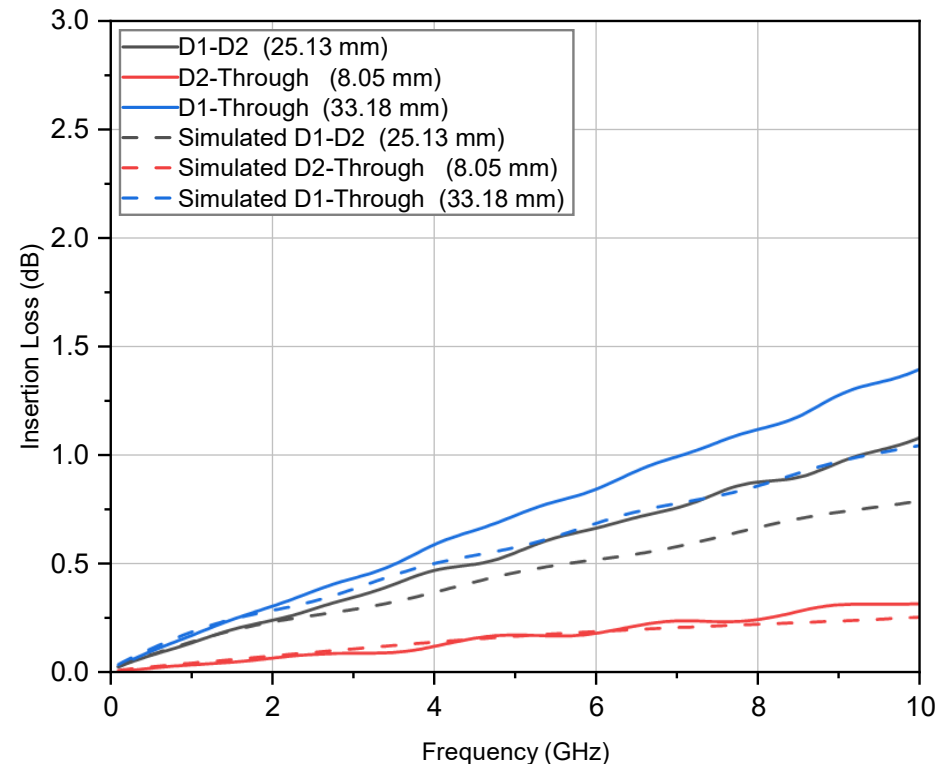
- Comparison of insertion losses of different microstrip lines and their simulated equivalents:



Some 'Before' Data



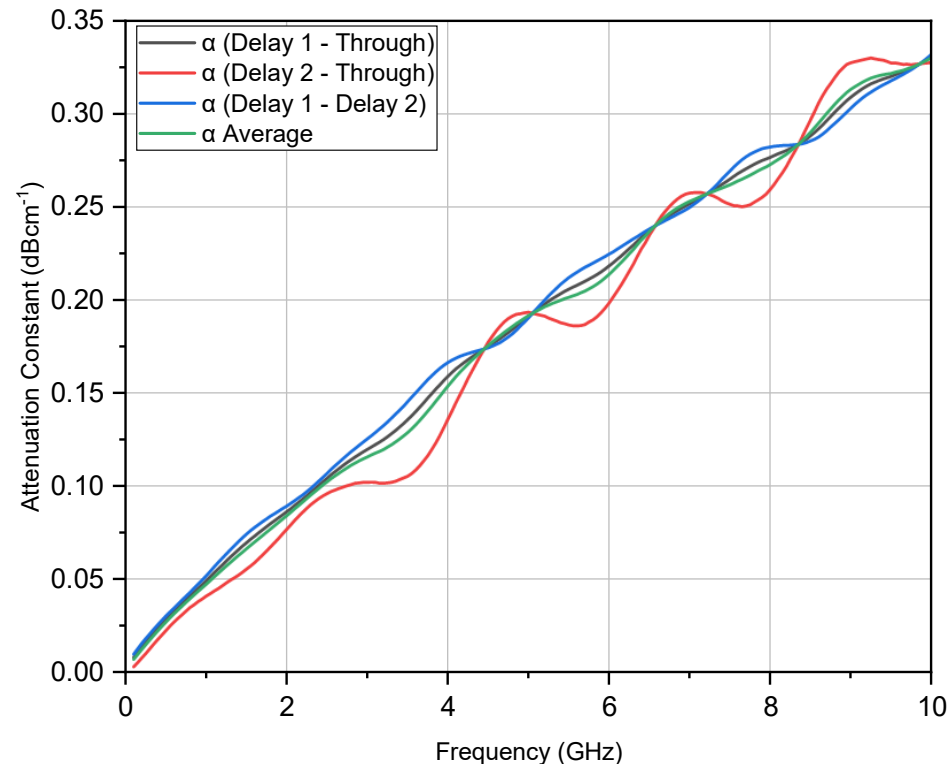
- Comparison of *differenced* insertion losses of different microstrip lines and their simulated equivalents:



Some 'Before' Data



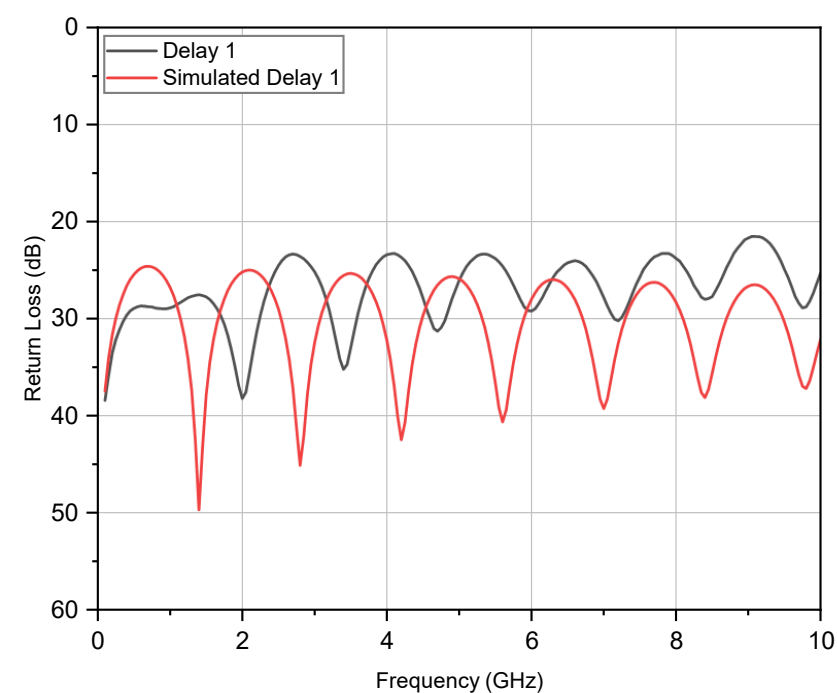
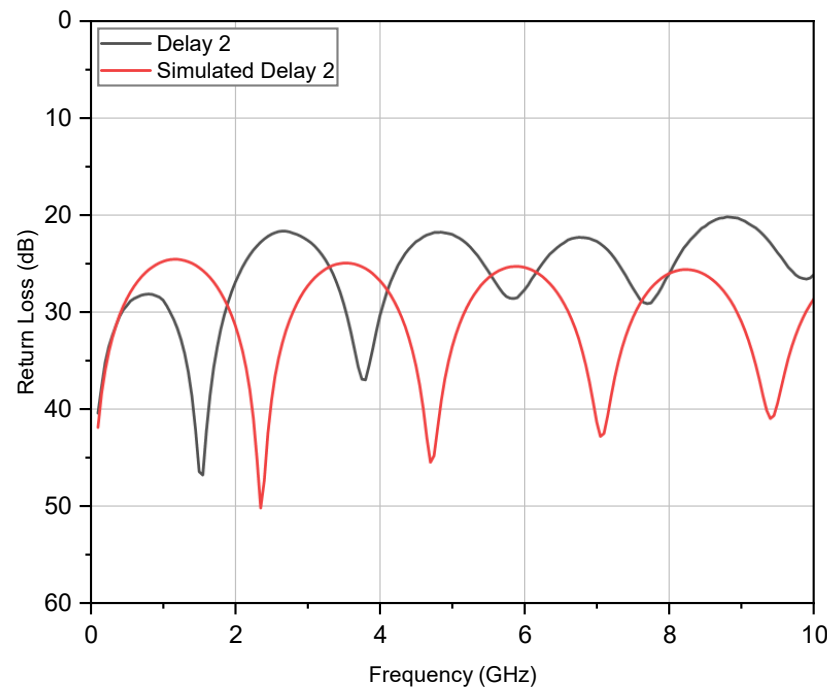
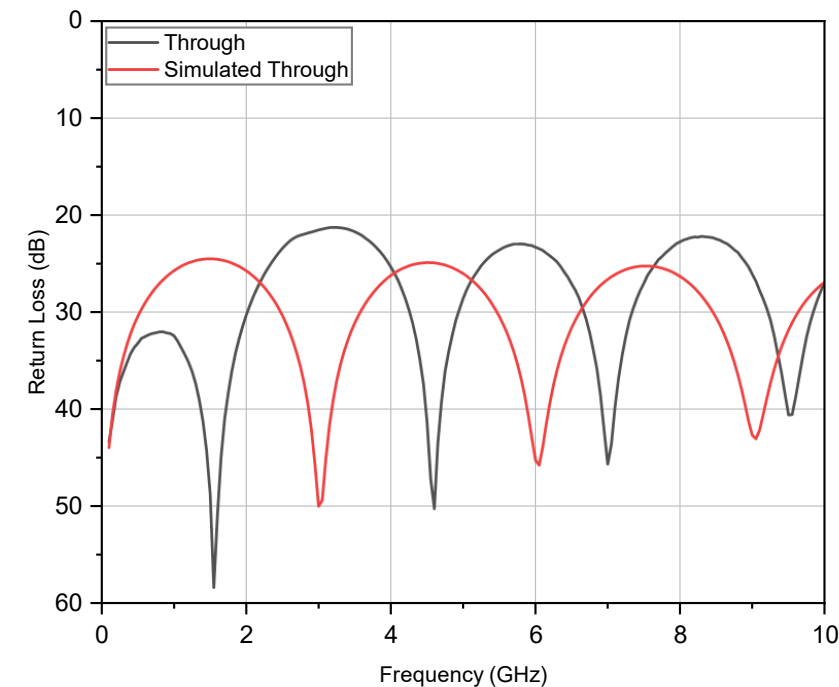
- Comparison of derived attenuation constant, α , from difference microstrip lines along with their average:



Some 'Before' Data



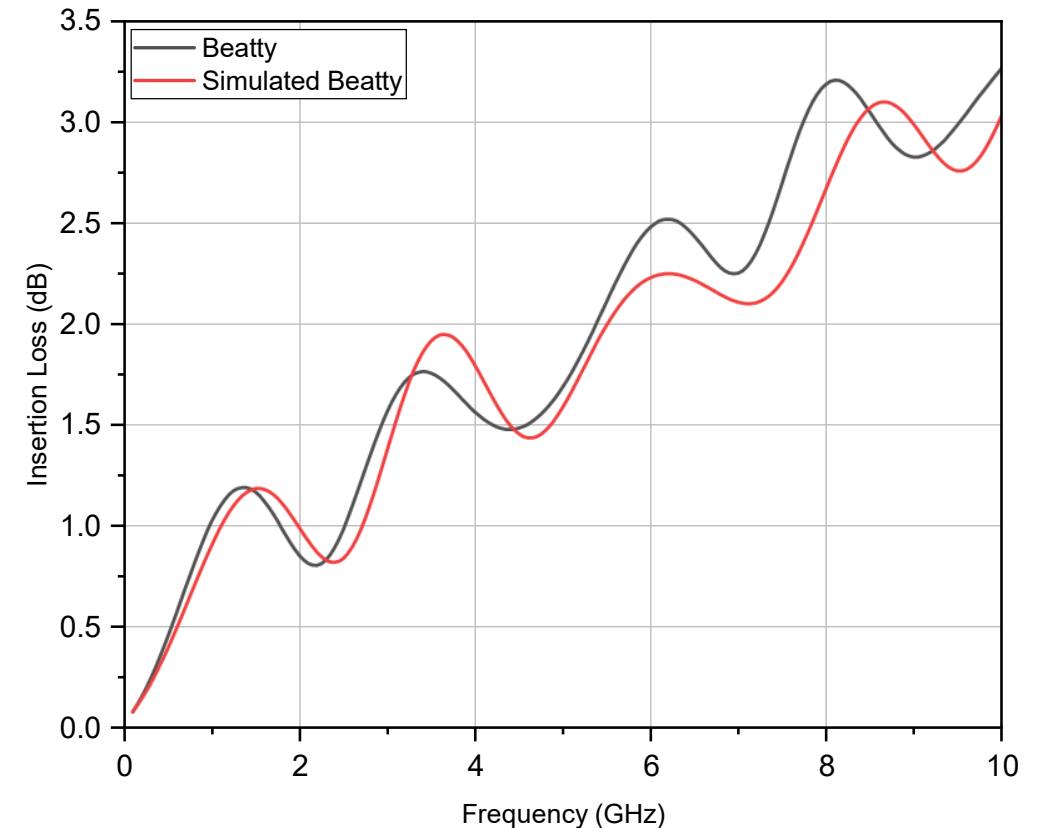
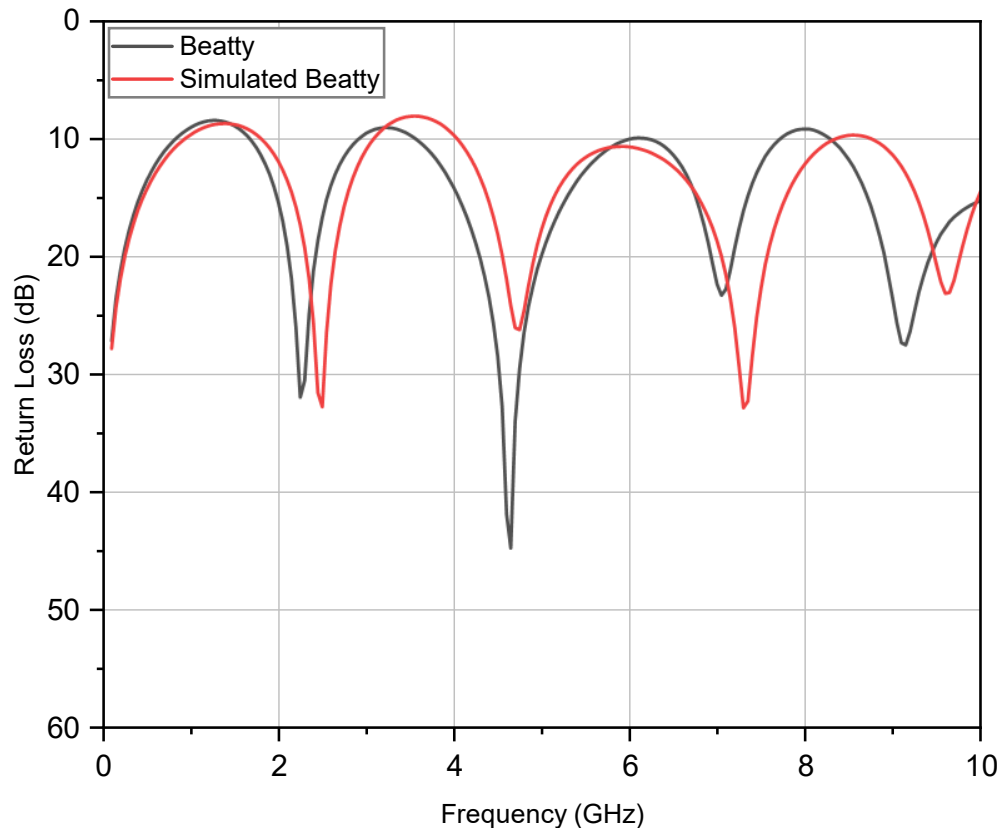
- Return loss comparison of the different microstrip lines and simulated equivalents; as the line's length is increased more ripple is observed
- Generally good return loss with minimum measured loss of around 20 dB



Some 'Before' Data



- Beatty line return loss and insertion loss with simulated equivalent circuit comparison:



Environmental Conditioning



- Thermal Cycling
 - - 40°C to 80°C, 500 cycles
- Damp Heat Testing
 - 85°C at 85 % humidity, 500 hours
- Isothermal Ageing
 - 125°C, 500 hours



PCB Thermal Cycling

Designing
the PCB

'Before'
Testing

Environmental
Conditioning

NPL 

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RF Measurements for future communications applications



A work in progress...

- Design improvements/optimisations?
- Testing different substrate materials at different bands?
- Testing different structures, transmission line types, active components?
- Testing stackups, layering of the PCBs?
- Different conditioning regimes?

- Any other suggestions?

Thanks for your attention



Contact details:

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